



LP2989LV Micropower and Low-Noise, 500-mA Ultra Low-Dropout Regulator for Use With Ceramic Output Capacitors

1 Features

- 2.1-V to 16-V Input Voltage Range
- Ultra-Low Dropout Voltage
- 500-mA Continuous Output Current
- Very Low Output Noise With External Capacitor
- < 0.8- μ A Quiescent Current When Shut Down
- Low Ground Pin Current at All Loads
- 0.75% Output Voltage Accuracy (A Grade)
- High Peak Current Capability (800-mA typical)
- Overtemperature and Overcurrent Protection
- -40°C to +125°C Junction Temperature Range

2 Applications

- Notebooks and Desktop PCs
- PDAs and Palmtop Computers
- Wireless Communication Pins
- SMPS Post-Regulators

3 Description

The LP2989LV is a fixed-output 500-mA precision LDO regulator designed for use with ceramic output capacitors.

Output noise can be reduced to 18 μ V (typical) by connecting an external 10-nF capacitor to the bypass pin.

Using an optimized Vertically Integrated PNP (VIP) process, the LP2989LV delivers superior performance:

Ground Pin Current: Typically 3 mA at 500-mA load, and 110 μ A at 100- μ A load.

Sleep Mode: The LP2989LV draws less than 0.8- μ A quiescent current when SHUTDOWN pin is pulled low.

ERROR Flag: The built-in **ERROR** flag goes low when the output drops approximately 5% below nominal.

Precision Output: Output voltage accuracy is 0.75% (A grade) and 1.25% (standard grade) at room temperature.

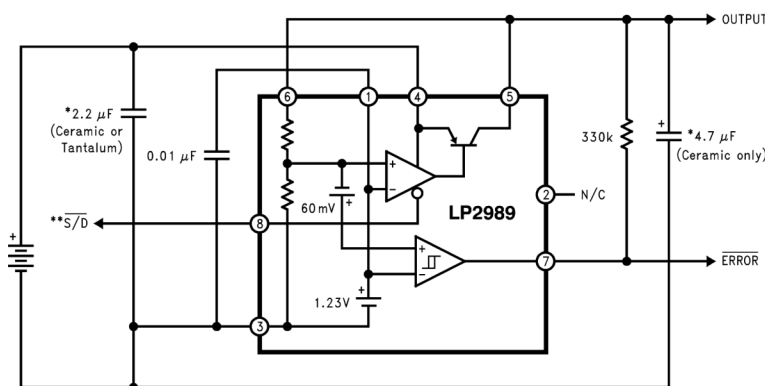
For output voltages greater than or equal to 2 V, see the LP2989 ([SNVS083](#)) data sheet.

Device Information⁽¹⁾

PART NUMBER	PACKAGE	BODY SIZE (NOM)
LP2989LV	WSON (8)	4.00 mm x 4.00 mm
	SOIC (8)	4.90 mm x 3.91 mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.

Typical Application



*Capacitance values shown are minimum required to assure stability, but may be increased without limit. Larger output capacitor provides improved dynamic response. See the [Output Capacitor](#) section.

**Shutdown must be actively terminated (see the [Shutdown Input Operation](#) section). Tie to IN (pin 4) if not use.



Table of Contents

1 Features	1	7.4 Device Functional Modes.....	10
2 Applications	1	8 Application and Implementation	11
3 Description	1	8.1 Application Information.....	11
4 Revision History	2	8.2 Typical Application	11
5 Pin Configuration and Functions	3	9 Power Supply Recommendations	15
6 Specifications	4	10 Layout	16
6.1 Absolute Maximum Ratings	4	10.1 Layout Guidelines	16
6.2 ESD Ratings.....	4	10.2 Layout Example	16
6.3 Recommended Operating Conditions.....	4	11 Device and Documentation Support	18
6.4 Thermal Information	4	11.1 Documentation Support	18
6.5 Electrical Characteristics.....	5	11.2 Community Resources.....	18
6.6 Typical Characteristics	7	11.3 Trademarks	18
7 Detailed Description	9	11.4 Electrostatic Discharge Caution.....	18
7.1 Overview	9	11.5 Glossary	18
7.2 Functional Block Diagram	9	12 Mechanical, Packaging, and Orderable	
7.3 Feature Description.....	9	Information	19

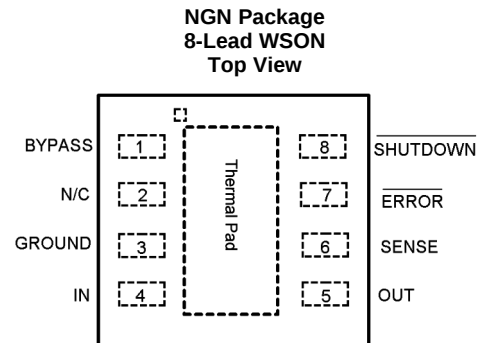
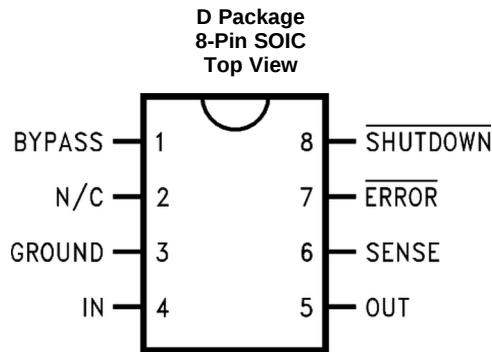
4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision J (April 2013) to Revision K	Page
• Changed "Wide Supply Voltage Range (16V Max)" to "2.1-V to 16-V Input Voltage Range" in <i>Features</i>	1
• Added <i>Handling Rating</i> table, <i>Feature Description</i> section, <i>Device Functional Modes</i> , <i>Application and Implementation</i> section, <i>Power Supply Recommendations</i> section, <i>Layout</i> section, <i>Device and Documentation Support</i> section, and <i>Mechanical, Packaging, and Orderable Information</i> section; add updated <i>Thermal Information</i> values; delete lead temperature from Ab Max (in POA); update pin names to TI nomenclature; removed reference to VSSOP package option (no longer available for this part number)	1
• Changed caption for Figure 11	8

Changes from Revision I (April 2013) to Revision J	Page
• Changed Changed layout of National data sheet to TI format	15

5 Pin Configuration and Functions



Pin Functions

PIN		I/O	DESCRIPTION
NAME	NUMBER		
BYPASS	1	I	Bypass capacitor input
<u>ERROR</u>	7	O	Error signal output
GROUND	3	—	GND
INPUT	4	I	Regulator power input
N/C	2	—	DO NOT CONNECT. Device pin 2 is reserved for post packaging test and calibration of the LP2989LV V_{OUT} accuracy. Device pin 2 must be left floating. Do not connect to any potential. Do not connect to ground. Any attempt to do pin continuity testing on device pin 2 is discouraged. Continuity test results are variable depending on the actions of the factory calibration. Aggressive pin continuity testing (high voltage, or high current) on device pin 2 may activate the trim circuitry forcing V_{OUT} to move out of tolerance.
OUTPUT	5	O	Regulated output voltage
SENSE	6	I	Feedback voltage sense input
<u>SHUTDOWN</u>	8	I	Shutdown input
Thermal Pad	—	—	The exposed thermal pad on the bottom of the WSON package must be connected to a copper thermal pad on the PCB under the package. The use of thermal vias to remove heat from the package into the PCB is recommended. Connect the thermal pad to ground potential or leave floating. Do not connect the thermal pad to any potential other than the same ground potential seen at device pin 3. For additional information on using TI's Non Pull Back WSON package, see Application Note AN-1187 <i>Leadless Leadframe Package (LLP)</i> (SNOA401).

6 Specifications

6.1 Absolute Maximum Ratings

If Military/Aerospace specified devices are required contact the Texas Instruments Sales Office/Distributors for availability and specifications.⁽¹⁾

	MIN	MAX	UNIT
Operating junction temperature	–40	125	°C
Power dissipation ⁽²⁾	Internally limited		
Input supply voltage, survival	–0.3	16	V
SENSE pin	–0.3	6	V
Output voltage, survival ⁽³⁾	–0.3	16	V
I _{OUT} , Survival	Short-circuit protected		
Input-output voltage, survival ⁽⁴⁾	–0.3	16	V
Storage temperature range, T _{stg}	–65	150	°C

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) The maximum allowable power dissipation is a function of the maximum junction temperature, T_{J(MAX)}, the junction-to-ambient thermal resistance, R_{θJA}, and the ambient temperature, T_A. The maximum allowable power dissipation at any ambient temperature is calculated using: $P_{(MAX)} = (T_{J(MAX)} - T_A) / R_{\theta JA}$. The value R_{θJA} for the WSON (NGN) package is specifically dependent on PCB trace area, trace material, and the number of layers and thermal vias. For improved thermal resistance and power dissipation for the WSON package, refer to Application Note AN-1187 *Leadless Leadframe Package (LLP)* ([SNOA401](#)). Exceeding the maximum allowable power dissipation causes excessive die temperature, and the regulator goes into thermal shutdown.
- (3) If used in a dual-supply system where the regulator load is returned to a negative supply, the LP2989LV output must be diode-clamped to ground.
- (4) The output PNP structure contains a diode between the IN and OUT pins that is normally reverse-biased. Forcing the output above the input turns on this diode and may induce a latch-up mode which can damage the part.

6.2 ESD Ratings

	VALUE	UNIT
V _(ESD) Electrostatic discharge Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±2000	V

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

	MIN	MAX	UNIT
Operating junction temperature	–40	125	°C
Operating input supply voltage	2.1	16	V

6.4 Thermal Information

THERMAL METRIC ⁽¹⁾		LP2989LV		UNIT
		NGN (WSON)	D (SOIC)	
		8 PINS	8 PINS	
R _{θJA}	Junction-to-ambient thermal resistance, High-K	34.8	114.5	°C/W
R _{θJC(top)}	Junction-to-case (top) thermal resistance	28.4	61.1	°C/W
R _{θJB}	Junction-to-board thermal resistance	12.0	55.6	°C/W
ψ _{JT}	Junction-to-top characterization parameter	0.2	9.7	°C/W
ψ _{JB}	Junction-to-board characterization parameter	12.2	54.9	°C/W
R _{θJC(bot)}	Junction-to-case (bottom) thermal resistance	1.3	n/a	°C/W

- (1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report, [SPRA953](#).

6.5 Electrical Characteristics

Unless otherwise specified: $T_J = 25^\circ\text{C}$, $V_{IN} = V_{OUT(NOM)} + 1\text{ V}$, $I_{OUT} = 1\text{ mA}$, $C_{OUT} = 4.7\text{ }\mu\text{F}$, $C_{IN} = 2.2\text{ }\mu\text{F}$, $V_{SD} = 2\text{ V}$.

PARAMETER	TEST CONDITIONS	LP2989LVAI-X.X ⁽¹⁾			LP2989LVI-X.X ⁽¹⁾			UNIT
		MIN	TYP	MAX	MIN	TYP	MAX	
V_{OUT} Output voltage tolerance		-0.75		0.75	-1.25		1.25	% V_{NOM}
	$1\text{ mA} < I_{OUT} < 500\text{ mA}$, $V_{OUT(NOM)} + 1\text{ V} \leq V_{IN} \leq 16\text{ V}$	-1.5		1.5	-2.5		2.5	
	$1\text{ mA} < I_{OUT} < 500\text{ mA}$, $V_{OUT(NOM)} + 1\text{ V} \leq V_{IN} \leq 16\text{ V}$, $-40^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$	-4		2.5	-5		3.5	
	$1\text{ mA} < I_{OUT} < 500\text{ mA}$, $V_{OUT(NOM)} + 1\text{ V} \leq V_{IN} \leq 16\text{ V}$, $-25^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$	-3.5		2.5	-4.5		3.5	
$\Delta V_{OUT}/\Delta V_{IN}$ Output voltage line regulation	$V_{OUT(NOM)} + 1\text{ V} \leq V_{IN} \leq 16\text{ V}$		0.005	0.014		0.005	0.014	%/ V
	$V_{OUT(NOM)} + 1\text{ V} \leq V_{IN} \leq 16\text{ V}$, $-40^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$		0.005	0.032		0.005	0.032	
$\Delta V_{OUT}/\Delta I_{OUT}$ Load regulation	$1\text{ mA} < I_{OUT} < 500\text{ mA}$		0.4			0.4		% V_{NOM}
V_{IN} (minimum) Minimum input voltage required to maintain output regulation	$V_{OUT} = 1.8\text{ V}$ $I_{OUT} = 100\text{ }\mu\text{A}$		1.96			1.96		V
	$V_{OUT} = 1.8\text{ V}$ $I_{OUT} = 250\text{ }\mu\text{A}$		1.98			1.98		
	$V_{OUT} = 1.8\text{ V}$ $I_{OUT} = 500\text{ }\mu\text{A}$		2.11			2.11		
I_{GND} Ground pin current	$I_{OUT} = 100\text{ }\mu\text{A}$		110	175		110	175	μA
	$I_{OUT} = 100\text{ }\mu\text{A}$, $-40^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$		110	200		110	200	
	$I_{OUT} = 200\text{ mA}$		1	2		1	2	mA
	$I_{OUT} = 200\text{ mA}$, $-40^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$		1	3.5		1	3.5	
	$I_{OUT} = 500\text{ mA}$		3	6		3	6	mA
	$I_{OUT} = 500\text{ mA}$, $-40^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$		3	9		3	9	
	$V_{SD} < 0.18\text{ V}$, $-40^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$		0.5	2		0.5	2	μA
	$V_{SD} < 0.4\text{ V}$		0.05	0.8		0.05	0.8	
$I_{OUT(PK)}$ Peak output current	$V_{OUT} \geq V_{OUT(NOM)} - 5\%$	600	800		600	800		mA
$I_{OUT(MAX)}$ Short circuit current	$R_L = 0$ (Steady State) ⁽²⁾		1000			1000		mA
e_n Output noise voltage (RMS)	$BW = 100\text{ Hz to }100\text{ kHz}$, $C_{OUT} = 10\text{ }\mu\text{F}$, $C_{BYPASS} = .01\text{ }\mu\text{F}$, $V_{OUT} = 2.5\text{ V}$		18			18		$\mu\text{V}_{(RMS)}$
$\Delta V_{OUT}/\Delta V_{IN}$ Ripple Rejection	$f = 1\text{ kHz}$, $C_{OUT} = 10\text{ }\mu\text{F}$		60			60		dB
$\Delta V_{OUT}/\Delta T_D$ Output voltage temperature coefficient	See ⁽³⁾ , $-40^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$		20			20		$\text{ppm}/^\circ\text{C}$

(1) Limits are 100% production tested at 25°C . Limits over the operating temperature range are specified through correlation using Statistical Quality Control (SQC) methods. The limits are used to calculate TI's Average Outgoing Quality Level (AOQL).

(2) See [Typical Characteristics](#).

(3) Temperature coefficient is defined as the maximum (worst-case) change divided by the total temperature range.

LP2989LV

SNVS086K –MAY 2000–REVISED JULY 2015

www.ti.com
Electrical Characteristics (continued)

Unless otherwise specified: $T_J = 25^\circ\text{C}$, $V_{IN} = V_{OUT(NOM)} + 1\text{ V}$, $I_{OUT} = 1\text{ mA}$, $C_{OUT} = 4.7\text{ }\mu\text{F}$, $C_{IN} = 2.2\text{ }\mu\text{F}$, $V_{SD} = 2\text{ V}$.

PARAMETER	TEST CONDITIONS	LP2989LVAI-X.X ⁽¹⁾			LP2989LVI-X.X ⁽¹⁾			UNIT		
		MIN	TYP	MAX	MIN	TYP	MAX			
SHUTDOWN INPUT										
$\overline{V_{SD}}$	$\overline{SD}$ Input voltage	V_H = Output ON			1.4			V		
		V_H = Output ON, $-40^{\circ}\text{C} \leq T_J \leq 125^{\circ}\text{C}$			1.6					
		V_L = Output OFF			0.5					
		V_L = Output OFF, $I_{IN} \leq 2\text{ }\mu\text{A}$, $-40^{\circ}\text{C} \leq T_J \leq 125^{\circ}\text{C}$			0.18					
$\overline{I_{SD}}$	$\overline{SD}$ Input current	$\overline{V_{SD}} = 0$			0.001			μA		
		$\overline{V_{SD}} = 0$, $-40^{\circ}\text{C} \leq T_J \leq 125^{\circ}\text{C}$			-1					
		$\overline{V_{SD}} = 5\text{ V}$			5					
		$\overline{V_{SD}} = 5\text{ V}$, $-40^{\circ}\text{C} \leq T_J \leq 125^{\circ}\text{C}$			15					
ERROR COMPARATOR										
I_{OH}	Output “HIGH” leakage	$V_{OH} = 16\text{ V}$			0.001			1	μA	
		$V_{OH} = 16\text{ V}$, $-40^{\circ}\text{C} \leq T_J \leq 125^{\circ}\text{C}$			0.001			2		
V_{OL}	Output “LOW” voltage	$V_{IN} = V_{OUT(NOM)} - 0.5\text{ V}$, $I_{OUT(Comp)} = 150\text{ }\mu\text{A}$			150			220	mV	
		$V_{IN} = V_{OUT(NOM)} - 0.5\text{ V}$, $I_{OUT(Comp)} = 150\text{ }\mu\text{A}$, $-40^{\circ}\text{C} \leq T_J \leq 125^{\circ}\text{C}$			150			350		
$V_{THR(MAX)}$	Upper threshold voltage				-6			-4.8	-3.5	% V_{OUT}
		$-40^{\circ}\text{C} \leq T_J \leq 125^{\circ}\text{C}$			-8.3			-4.8	-2.5	
$V_{THR(MIN)}$	Lower threshold voltage				-8.9			-6.6	-4.9	% V_{OUT}
		$-40^{\circ}\text{C} \leq T_J \leq 125^{\circ}\text{C}$			-13			-6.6	-3	
HYST	Hysteresis				2					

6.6 Typical Characteristics

Unless otherwise specified: $T_A = 25^\circ\text{C}$, $C_{OUT} = 10\ \mu\text{F}$, $C_{IN} = 2.2\ \mu\text{F}$, $\overline{\text{SD}}$ is tied to V_{IN} , $V_{IN} = V_{O(NOM)} + 1\ \text{V}$, $I_L = 1\ \text{mA}$, $V_{OUT} = 1.8\ \text{V}$.

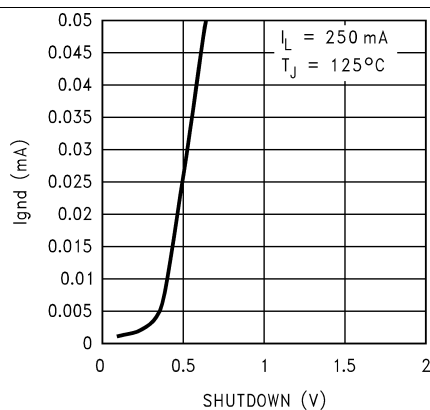


Figure 1. I_{GND} vs Shutdown

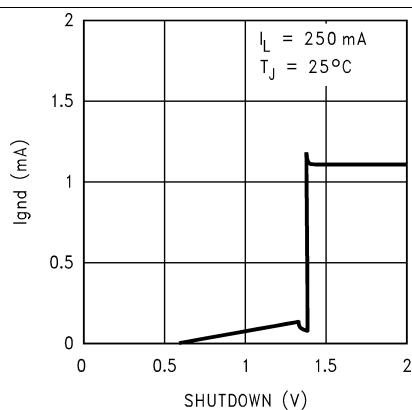


Figure 2. I_{GND} vs Shutdown

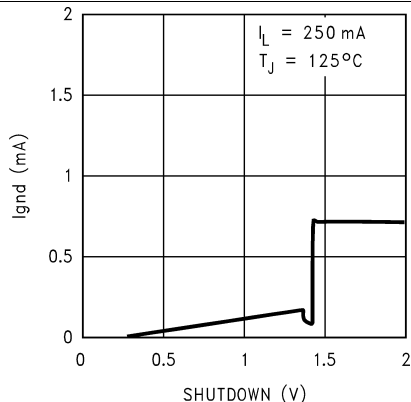


Figure 3. I_{GND} vs Shutdown

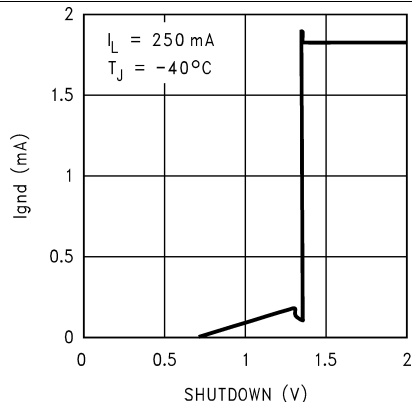


Figure 4. I_{GND} vs Shutdown

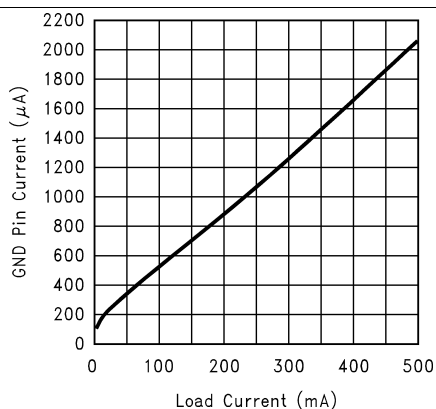


Figure 5. Ground Pin Current vs Load Current

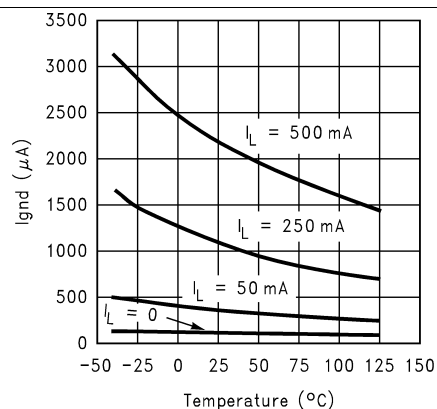


Figure 6. GND Pin Current vs Temperature and Load

Typical Characteristics (continued)

Unless otherwise specified: $T_A = 25^\circ\text{C}$, $C_{OUT} = 10\ \mu\text{F}$, $C_{IN} = 2.2\ \mu\text{F}$, $\overline{SD}$ is tied to V_{IN} , $V_{IN} = V_{O(NOM)} + 1\ \text{V}$, $I_L = 1\ \text{mA}$, $V_{OUT} = 1.8\ \text{V}$.

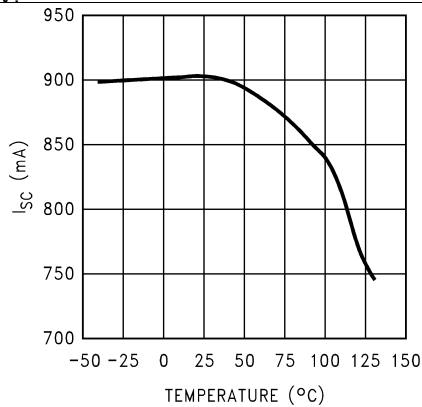


Figure 7. Short-Circuit Current vs Temperature

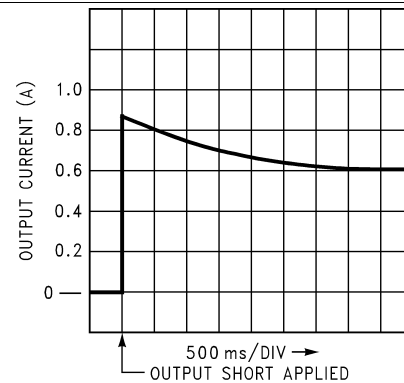


Figure 8. Short-Circuit Current

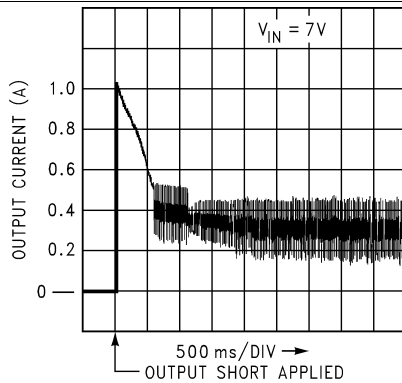


Figure 9. Short-Circuit Current

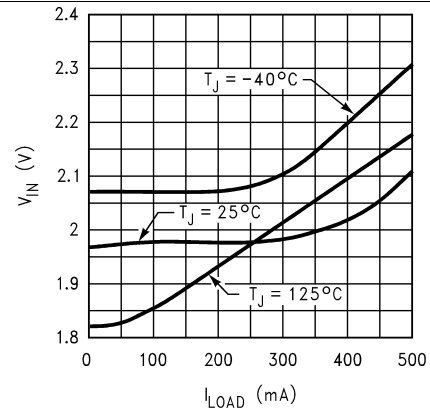


Figure 10. Minimum V_{IN} vs Load Current

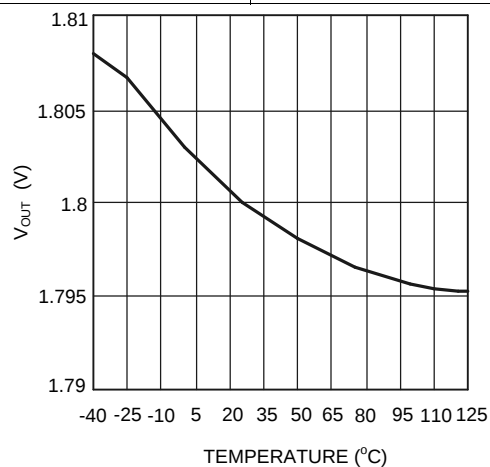


Figure 11. V_{OUT} vs Junction Temperature (T_J)

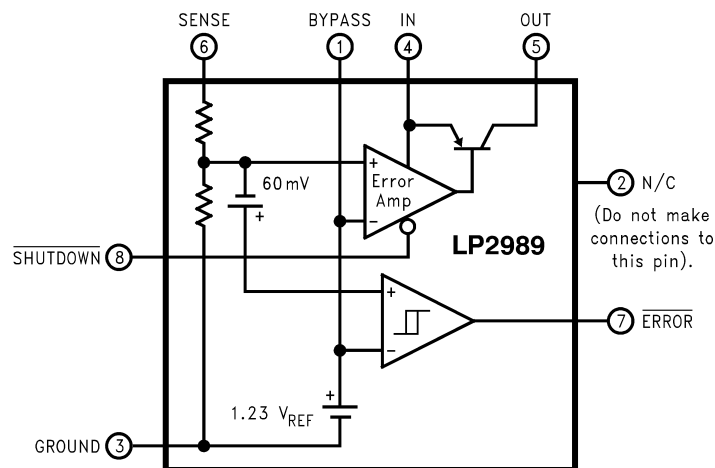
7 Detailed Description

7.1 Overview

The LP2989LV device is a very high-accuracy micro-power voltage regulator with low quiescent current (75 μ A typical) and low dropout voltage (typical 40 mV at light loads and 380 mV at 100 mA). It is ideally suited for use in battery-powered systems. The LP2989LV block diagram contains several features, including:

- Very high-accuracy 1.23-V reference
- SHUTDOWN input
- ERROR flag output
- Internal protection circuitry, such as foldback current limit, and thermal shutdown.

7.2 Functional Block Diagram



7.3 Feature Description

7.3.1 High-Accuracy Output Voltage

With special careful design to minimize all contributions to the output voltage error, the LP2989LV distinguishes itself as a very high output-voltage-accuracy micropower LDO. This includes a tight initial tolerance (0.75% typical, A grade), extremely good line regulation (0.005%/V typical), and a very low output-noise voltage (10 μ V_{RMS} typical), making the device an ideal low-power voltage reference.

7.3.2 Sleep Mode

When pulling SHUTDOWN pin to low levels, the LP2989LV enters shutdown mode, and a very low quiescent current is consumed. This function is designed for applications which needs a shutdown mode to effectively enhance battery life cycle.

7.3.3 Error Detection Comparator Output

The LP2989LV generates a logic low output whenever its output falls out of regulation by more than approximately 5%. Refer to [Application and Implementation](#) for more details.

7.3.4 Short Circuit Protection (Current Limit)

The internal current limit circuit is used to protect the LDO against high-load current faults or shorting events. The LDO is not designed to operate in a steady-state current limit. During a current-limit event, the LDO sources constant current. Therefore, the output voltage falls when load impedance decreases. Note also that if a current limit occurs and the resulting output voltage is low, excessive power may be dissipated across the LDO, resulting in a thermal shutdown of the output. A foldback feature limits the short-circuit current to protect the regulator from damage under all load conditions. If OUT is forced below 0 V before EN goes high and the load current required exceeds the foldback current limit, the device may not start correctly.

Feature Description (continued)

7.3.5 Thermal Protection

The device contains a thermal shutdown protection circuit to turn off the output current when excessive heat is dissipated in the LDO. The thermal time-constant of the semiconductor die is fairly short, and thus the output cycles on and off at a high rate when thermal shutdown is reached until the power dissipation is reduced. The internal protection circuitry of the device is designed to protect against thermal overload conditions. The circuitry is not intended to replace proper heat sinking. Continuously running the device into thermal shutdown degrades its reliability.

7.4 Device Functional Modes

7.4.1 Operation With $16\text{ V} \geq V_{\text{IN}} > V_{\text{OUT(TARGET)}} + 1\text{ V}$

The device operates if the input voltage is equal to, or exceeds $V_{\text{OUT(TARGET)}} + 1\text{ V}$. At input voltages below the minimum V_{IN} requirement, the devices does not operate correctly, and output voltage may not reach target value.

7.4.2 Operation with Shutdown Control

If the voltage on the $\overline{\text{SHUTDOWN}}$ pin is less than 0.18 V, the output is ensured to be OFF. When the voltage on the $\overline{\text{SHUTDOWN}}$ pin is more than 1.6 V the output is ensured to be ON. Operating with the $\overline{\text{SHUTDOWN}}$ pin voltage between 0.18 V and 1.6 V is strongly discouraged as the status of the output is not ensured.

7.4.3 Shutdown Input Operation

The LP2989LV is shut off by driving the $\overline{\text{SHUTDOWN}}$ pin low, and turned on by pulling it high. If this feature is not to be used, the $\overline{\text{SHUTDOWN}}$ must be tied to V_{IN} to keep the regulator output on at all times.

To assure proper operation, the signal source used to drive the Shutdown input must be able to swing above and below the specified turn-on/turn-off voltage thresholds listed in [Electrical Characteristics](#) under V_{SD} .

To prevent mis-operation, the turnon (and turnoff) voltage signals applied to the $\overline{\text{SHUTDOWN}}$ input must have a slew rate which is $\geq 40\text{ mV}/\mu\text{s}$.

CAUTION

The regulator output voltage **cannot** be ensured if a slow-moving AC (or DC) signal is applied that is in the range between the specified turn-on and turn-off voltages listed under the electrical specification V_{SD} (see [Electrical Characteristics](#)).

8 Application and Implementation

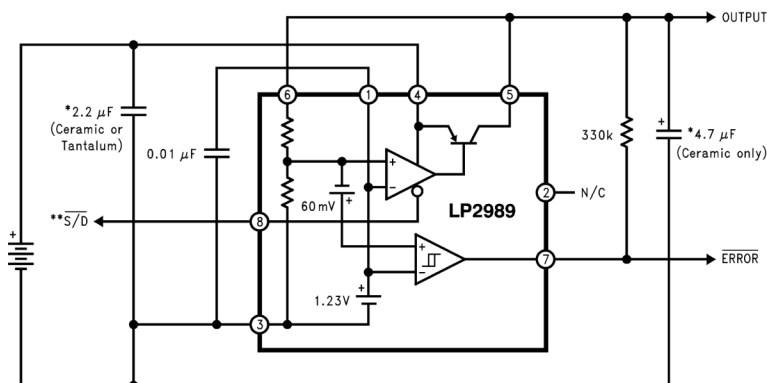
NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

8.1 Application Information

The LP2989LV is a linear voltage regulator operating from 2.1 V to 16 V on the input and regulates voltages between 2.5 V to 5 V with 0.75% accuracy and 500-mA maximum output current. Efficiency is defined by the ratio of output voltage to input voltage because the LP2989LV is a linear voltage regulator. To achieve high efficiency, the dropout voltage ($V_{IN} - V_{OUT}$) must be as small as possible, thus requiring a very low dropout LDO. Successfully implementing an LDO in an application depends on the application requirements. If the requirements are simply input voltage and output voltage, compliance specifications (such as internal power dissipation or stability) must be verified to ensure a solid design. If timing, start-up, noise, PSRR, or any other transient specification is required, the design becomes more challenging.

8.2 Typical Application



*Capacitance values shown are minimum required to assure stability, but may be increased without limit. Larger output capacitor provides improved dynamic response. See the [Output Capacitor](#) section.

**SHUTDOWN must be actively terminated (see the [Shutdown Input Operation](#) section). Tie to IN (pin 4) if not use.

Figure 12. Typical Application Schematic

8.2.1 Design Requirements

For typical linear regulator applications, use the parameters in [Table 1](#)

Table 1. Design Parameters

DESIGN PARAMETER	DESIGN REQUIREMENT
Input voltage	6.5 V, $\pm 10\%$,
Output voltage	5 V, $\pm 1\%$
Output current	500 mA (maximum), 1 mA (minimum)
RMS noise, 100 Hz to 100 kHz	18 $\mu V_{(RMS)}$ typical
PSRR at 1 kHz	60 dB typical

8.2.2 Detailed Design Procedure

At 500-mA loading, the dropout of the LP2989LV has 650-mV maximum dropout over temperature, thus an 1500-mV headroom is sufficient for operation over both input and output voltage accuracy. The efficiency of the LP2989LV in this configuration is $V_{OUT} / V_{IN} = 76.9\%$. To achieve the smallest form factor, the WSON package is selected. Input and output capacitors are selected in accordance with the capacitor recommendations. Ceramic capacitances of 2.2 μF for the input and one 4.7- μF capacitor for the output are selected. With an efficiency of 76.9% and a 500-mA maximum load, the internal power dissipation is 750 mW, which corresponds to a 26.1°C junction temperature rise for the WSON package. With an 85°C maximum ambient temperature, the junction temperature is at 111.1°C. To minimize noise, a bypass capacitance (C_{BYPASS}) of 0.01 μF is placed from the BYPASS pin (device pin 1) to device ground (device pin 3).

8.2.2.1 WSON Package Devices

The LP2989LV is offered in the 8-lead WSON surface mount package to allow for increased power dissipation compared to the SOIC package. For details on thermal performance as well as mounting and soldering specifications, refer to Application Note AN-1187 *Leadless Leadframe Package (LLP)* ([SNOA401](#)).

For output voltages $\geq 2\text{ V}$, see LP2989LV ([SNVS083](#)) data sheet.

8.2.2.2 External Capacitors

Like any low-dropout regulator, the LP2989LV requires external capacitors for regulator stability. These capacitors must be correctly selected for good performance.

8.2.2.2.1 Input Capacitor

An input capacitor whose value is at least 2.2 μF is required between the LP2989LV input and ground (the amount of capacitance may be increased without limit).

Characterization testing performed on the LP2989LV has shown that if the value of actual input capacitance drops below about 1.5 μF , an unstable operating condition may result. Therefore, the next larger standard size (2.2 μF) is specified as the minimum required input capacitance. Capacitor tolerance and temperature variation must be considered when selecting a capacitor (see [Capacitor Characteristics](#) section) to assure the minimum requirement of 1.5 μF is met over all operating conditions.

The input capacitor must be located at a distance of not more than 0.5 inches from the input pin and returned to a clean analog ground. Any good quality ceramic or tantalum may be used for this capacitor, assuming the minimum capacitance requirement is met.

8.2.2.2.2 Output Capacitor

The LP2989LV requires a ceramic output capacitor whose value is at least 10 μF . The actual amount of capacitance on the output must never drop below about 7 μF or unstable operation may result. For this reason, capacitance tolerance and temperature characteristics must be considered when selecting an output capacitor.

The LP2989LV is designed specifically to work with ceramic output capacitors, using circuitry which allows the regulator to be stable across the entire range of output current with an output capacitor whose ESR is as low as 4 m Ω . It may also be possible to use Tantalum or film capacitors at the output, but these are not as attractive for reasons of size and cost (see [Capacitor Characteristics](#)).

The output capacitor must meet the requirement for minimum amount of capacitance and also have an equivalent series resistance (ESR) value which is within the stable range. Curves are provided which show the stable ESR range as a function of load current (see [Figure 13](#)).

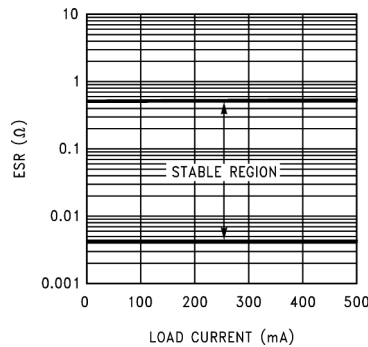


Figure 13. Stable Region for Output Capacitor ESR

NOTE

Important: The output capacitor must maintain its ESR within the stable region over the full operating temperature range of the application to assure stability.

It is important to remember that capacitor tolerance and variation with temperature must be considered when selecting an output capacitor so that the minimum required amount of output capacitance is provided over the full operating temperature range. (See [Capacitor Characteristics](#).)

The output capacitor must be located not more than 0.5 inches from the OUT pin and returned to a clean analog ground.

8.2.2.2.3 Noise Bypass Capacitor

Connecting a 10-nF capacitor to the BYPASS pin significantly reduces noise on the regulator output. However, the capacitor is connected directly to a high-impedance circuit in the bandgap reference.

Because this circuit has only a few microamperes flowing in it, any significant loading on this node causes the regulated output voltage to drop. For this reason, DC leakage current through the noise bypass capacitor must never exceed 100 nA, and must be kept as low as possible for best output voltage accuracy.

The types of capacitors best suited for the noise bypass capacitor are ceramic and film. High-quality ceramic capacitors with either NPO or COG dielectric typically have very low leakage. 10-nF polypropylene and polycarbonate film capacitors are available in small surface-mount packages and typically have extremely low leakage current.

8.2.2.3 Capacitor Characteristics

8.2.2.3.1 Ceramic

The LP2989LV was designed to work with ceramic capacitors on the output to take advantage of the benefits they offer: for capacitance values in the 10 μ F range, ceramics are the least expensive and also have the lowest ESR values (which makes them best for eliminating high-frequency noise). The ESR of a typical 10- μ F ceramic capacitor is in the range of 5 m Ω to 10 m Ω , which easily meets the ESR limits required for stability by the LP2989LV.

One disadvantage of ceramic capacitors is that their capacitance can vary with temperature. Many large-value ceramic capacitors ($\geq 2.2 \mu$ F) are manufactured with the Z5U or Y5V temperature characteristic, which results in the capacitance dropping by more than 50% as the temperature goes from 25°C to 85°C.

This could cause problems if a 10- μ F Y5V capacitor were used on the output because it drops down to approximately 5 μ F at high ambient temperatures (which could cause the LP2989LV to oscillate). Another significant problem with Z5U and Y5V dielectric devices is that the capacitance drops severely with applied voltage. A typical Z5U or Y5V capacitor can lose 60% of its rated capacitance with half of the rated voltage applied to it.

For these reasons, X7R and X5R type ceramic capacitors must be used on the input and output of the LP2989LV.

8.2.2.3.2 Tantalum

Tantalum output capacitors are not recommended for use with the LP2989LV; they are less desirable than ceramics for use as output capacitors because they are typically more expensive when comparing equivalent capacitance and voltage ratings in the 1 μF to 10 μF range

Another important consideration is that tantalum capacitors have higher ESR values than equivalent size ceramics; while it may be possible to find a Tantalum capacitor with an ESR value within the stable range, it would have to be larger in capacitance (which means bigger and more costly) than a ceramic capacitor with the same ESR value.

Most 10- μF tantalum capacitors have ESR values higher than 0.5 Ω maximum limit required to make the LP2989LV stable. Also note that the ESR of a typical tantalum increases about 2:1 as the temperature goes from 25°C down to -40°C, so some guard band must be allowed.

8.2.2.3.3 Film

Polycarbonate and polypropylene film capacitors have excellent electrical performance: their ESR is the lowest of the three types listed, their capacitance is very stable with temperature, and DC leakage current is extremely low.

One disadvantage is that film capacitors are larger in physical size than ceramic or tantalum which makes film a poor choice for either input or output capacitors.

However, their low leakage makes them a good choice for the noise bypass capacitor. Because the required amount of capacitance is only 0.01 μF , small surface-mount film capacitors are available in this size.

8.2.2.4 Reverse Input-Output Voltage

The PNP power transistor used as the pass element in the LP2989LV has an inherent diode connected between the regulator output and input.

During normal operation (where the input voltage is higher than the output) this diode is reverse-biased.

However, if the output is pulled above the input, this diode turns on, and current flows into the regulator output.

In such cases, a parasitic SCR can latch which allows high current to flow into V_{IN} can damage the part.

In any application where the output may be pulled above the input, an external Schottky diode must be connected from V_{IN} to V_{OUT} (cathode on V_{IN} , anode on V_{OUT}), to limit the reverse voltage across the LP2989LV to 0.3 V (see [Absolute Maximum Ratings](#)).

8.2.3 Application Curves

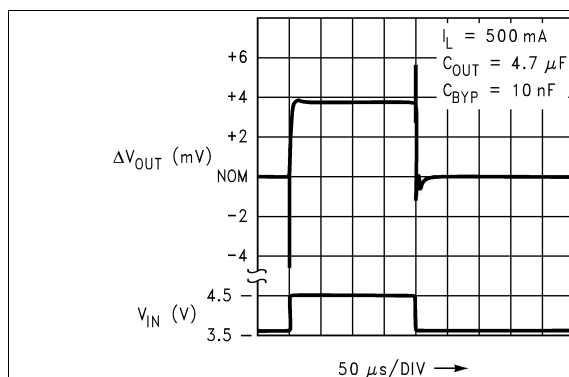


Figure 14. Line Transient Response

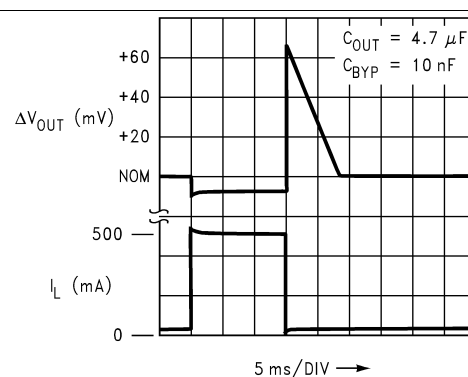


Figure 15. Load Transient Response

9 Power Supply Recommendations

The LP2989LV is designed to operate from an input voltage supply range from 2.1 V to 16 V. The input voltage range provides adequate headroom for the device to have a regulated output. This input supply must be well regulated. If the input supply is noisy, additional input capacitors with low ESR can help improve the output noise performance.

10 Layout

10.1 Layout Guidelines

For best overall performance, place all circuit components on the same side of the circuit board and as near as practical to the respective LDO pin connections. Place ground return connections to the input and output capacitor, and to the LDO ground pin as close to each other as possible, connected by a wide, component-side, copper surface. The use of vias and long traces to create LDO circuit connections is strongly discouraged and negatively affects system performance. This grounding and layout scheme minimizes inductive parasitics, and thereby reduces load-current transients, minimizes noise, and increases circuit stability. A ground reference plane is also recommended and is either embedded in the PCB itself or located on the bottom side of the PCB opposite the components. This reference plane serves to assure accuracy of the output voltage, shield noise, and behaves similarly to a thermal plane to spread (or sink) heat from the LDO device. In most applications, this ground plane is necessary to meet thermal requirements.

10.2 Layout Example

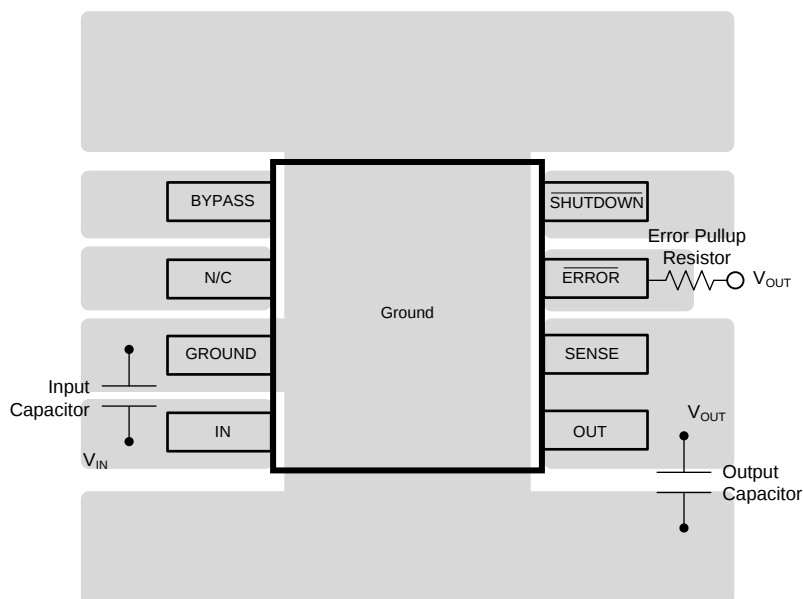


Figure 16. LP2989LV Layout Example

10.2.1 Thermal Considerations

CAUTION

Due to the limited power dissipation characteristics of the available SOIC (D) and WSON (NGN) packages, all possible combinations of output current (I_{OUT}), input voltage (V_{IN}), and ambient temperatures (T_A) cannot be ensured.

Power dissipation, P_D is calculated from the following formula:

$$P_D = (V_{IN} - V_{OUT}) \times I_{OUT} \quad (1)$$

The LP2989LV regulator has internal thermal limiting designed to protect the device during overload conditions. For continuous normal conditions, the recommended maximum operating junction temperature is 125°C. It is important to give careful consideration to all sources of thermal resistance from junction to ambient. Additional heat sources mounted nearby must also be considered.

For surface-mount devices, heat sinking is accomplished by using the heat-spreading capabilities of the PC board and its copper traces. Copper board stiffeners and plated through-holes can also be used to spread the heat generated by power devices.

Layout Example (continued)

Example: Given an output voltage of 1.8 V, an input voltage range of 4 V to 6 V, a maximum output current of 100 mA, and a maximum ambient temperature of 50°C, what is the maximum operating junction temperature? The maximum power dissipated by the device ($P_{D(MAX)}$) is found using the formula in [Equation 2](#):

$$P_{D(MAX)} = (V_{IN(MAX)} - V_{OUT}) \times I_{OUT(MAX)} \quad (2)$$

Using [Equation 2](#), the result is:

$$P_{D(MAX)} = ((6 \text{ V} - 1.8 \text{ V}) \times 100 \text{ mA}) = 0.42 \text{ W}$$

when

- $I_{OUT(MAX)} = 100 \text{ mA}$
- $V_{IN(MAX)} = 6 \text{ V}$
- $V_{OUT} = 1.8 \text{ V}$

Using the 8-pin SOIC (D) package, the LP2989LV junction-to-ambient thermal resistance ($R_{\theta JA}$) has a rating of 114.5°C/W using the standard JEDEC JESD51-7 PCB (High-K) circuit board.

$$T_{RISE} = P_{D(MAX)} \times R_{\theta JA} \quad (3)$$

Thus, The junction temperature rise above ambient (T_{RISE}) using the formula in [Equation 3](#) is:

$$T_{RISE} = 0.42 \text{ W} \times 114.5^\circ\text{C/W} = 48.1^\circ\text{C}$$

The junction temperature rise can then be added to the maximum ambient temperature to find the estimated operating junction temperature (T_J) using the formula in [Equation 4](#):

$$T_{J(MAX)} = T_{A(MAX)} + T_{RISE} \quad (4)$$

which gives the following results:

$$T_{J(MAX)} = 50^\circ\text{C} + 48.1^\circ\text{C} = 98.1^\circ\text{C}$$

11 Device and Documentation Support

11.1 Documentation Support

11.1.1 Related Documentation

For related documentation see the following:

LP2989 ([SNVS083](#)) data sheet

Application Note AN-1187 *Leadless Leadframe Package (LLP)* ([SNOA401](#)).

11.2 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

TI E2E™ Online Community *TI's Engineer-to-Engineer (E2E) Community*. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

11.3 Trademarks

E2E is a trademark of Texas Instruments.

All other trademarks are the property of their respective owners.

11.4 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

11.5 Glossary

[SLYZ022](#) — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
LP2989AIM-1.8/NOPB	Active	Production	SOIC (D) 8	95 TUBE	Yes	SN	Level-1-260C-UNLIM	-40 to 125	2989A IM1.8
LP2989AIM-1.8/NOPB.A	Active	Production	SOIC (D) 8	95 TUBE	Yes	SN	Level-1-260C-UNLIM	-40 to 125	2989A IM1.8
LP2989AIM-1.8/NOPB.B	Active	Production	SOIC (D) 8	95 TUBE	Yes	SN	Level-1-260C-UNLIM	-40 to 125	2989A IM1.8
LP2989AIMX-1.8/NO.A	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	2989A IM1.8
LP2989AIMX-1.8/NOPB	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	2989A IM1.8
LP2989IM-1.8/NOPB	Active	Production	SOIC (D) 8	95 TUBE	Yes	SN	Level-1-260C-UNLIM	-40 to 125	2989 IM1.8
LP2989IM-1.8/NOPB.A	Active	Production	SOIC (D) 8	95 TUBE	Yes	SN	Level-1-260C-UNLIM	-40 to 125	2989 IM1.8
LP2989IM-1.8/NOPB.B	Active	Production	SOIC (D) 8	95 TUBE	Yes	SN	Level-1-260C-UNLIM	-40 to 125	2989 IM1.8
LP2989IMX-1.8/NOPB	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	2989 IM1.8
LP2989IMX-1.8/NOPB.A	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	2989 IM1.8
LP2989IMX-1.8/NOPB.B	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	2989 IM1.8

⁽¹⁾ **Status:** For more details on status, see our [product life cycle](#).

⁽²⁾ **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

⁽⁴⁾ **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

TAPE AND REEL INFORMATION



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
LP2989AIMX-1.8/NOPB	SOIC	D	8	2500	330.0	12.4	6.5	5.4	2.0	8.0	12.0	Q1
LP2989IMX-1.8/NOPB	SOIC	D	8	2500	330.0	12.4	6.5	5.4	2.0	8.0	12.0	Q1

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
LP2989AIMX-1.8/NOPB	SOIC	D	8	2500	367.0	367.0	35.0
LP2989IMX-1.8/NOPB	SOIC	D	8	2500	367.0	367.0	35.0

TUBE



*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (μm)	B (mm)
LP2989AIM-1.8/NOPB	D	SOIC	8	95	495	8	4064	3.05
LP2989AIM-1.8/NOPB.A	D	SOIC	8	95	495	8	4064	3.05
LP2989AIM-1.8/NOPB.B	D	SOIC	8	95	495	8	4064	3.05
LP2989IM-1.8/NOPB	D	SOIC	8	95	495	8	4064	3.05
LP2989IM-1.8/NOPB.A	D	SOIC	8	95	495	8	4064	3.05
LP2989IM-1.8/NOPB.B	D	SOIC	8	95	495	8	4064	3.05



PACKAGE OUTLINE

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 [0.15] per side.
4. This dimension does not include interlead flash.
5. Reference JEDEC registration MS-012, variation AA.

EXAMPLE BOARD LAYOUT

D0008A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



4214825/C 02/2019

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

D0008A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



SOLDER PASTE EXAMPLE
BASED ON .005 INCH [0.125 MM] THICK STENCIL
SCALE:8X

4214825/C 02/2019

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATASHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you fully indemnify TI and its representatives against any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to [TI's Terms of Sale](#), [TI's General Quality Guidelines](#), or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products. Unless TI explicitly designates a product as custom or customer-specified, TI products are standard, catalog, general purpose devices.

TI objects to and rejects any additional or different terms you may propose.

Copyright © 2026, Texas Instruments Incorporated

Last updated 10/2025